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# Understanding <u>Embedded - FPGAs (Field Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

## **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Obsolete
Number of LABs/CLBs	416
Number of Logic Elements/Cells	4160
Total RAM Bits	53248
Number of I/O	183
Number of Gates	263000
Voltage - Supply	1.71V ~ 1.89V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	240-BFQFP
Supplier Device Package	240-PQFP (32x32)
Purchase URL	https://www.e-xfl.com/product-detail/intel/ep20k100eqc240-2n

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

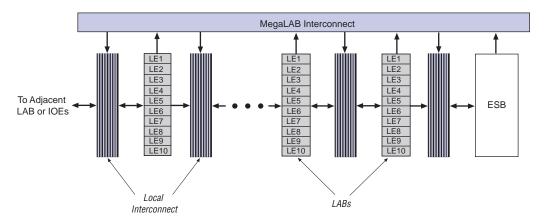
Feature	APEX 20K Devices	APEX 20KE Devices
MultiCore system integration	Full support	Full support
SignalTap logic analysis	Full support	Full support
32/64-Bit, 33-MHz PCI	Full compliance in -1, -2 speed grades	Full compliance in -1, -2 speed grades
32/64-Bit, 66-MHz PCI	-	Full compliance in -1 speed grade
MultiVolt I/O	2.5-V or 3.3-V V <sub>CCIO</sub> V <sub>CCIO</sub> selected for device Certain devices are 5.0-V tolerant	1.8-V, 2.5-V, or 3.3-V V <sub>CCIO</sub> V <sub>CCIO</sub> selected block-by-block 5.0-V tolerant with use of external resistor
ClockLock support	Clock delay reduction 2× and 4× clock multiplication	Clock delay reduction $m/(n \times v)$ or $m/(n \times k)$ clock multiplication Drive ClockLock output off-chip External clock feedback ClockShift LVDS support Up to four PLLs ClockShift, clock phase adjustment
Dedicated clock and input pins	Six	Eight
I/O standard support	2.5-V, 3.3-V, 5.0-V I/O 3.3-V PCI Low-voltage complementary metal-oxide semiconductor (LVCMOS) Low-voltage transistor-to-transistor logic (LVTTL)	1.8-V, 2.5-V, 3.3-V, 5.0-V I/O 2.5-V I/O 3.3-V PCI and PCI-X 3.3-V Advanced Graphics Port (AGP) Center tap terminated (CTT) GTL+ LVCMOS LVTTL True-LVDS and LVPECL data pins (in EP20K300E and larger devices) LVDS and LVPECL signaling (in all BGA and FineLine BGA devices) LVDS and LVPECL data pins up to 156 Mbps (in -1 speed grade devices) HSTL Class I PCI-X SSTL-2 Class I and II SSTL-3 Class I and II
Memory support	Dual-port RAM FIFO RAM ROM	CAM Dual-port RAM FIFO RAM ROM

APEX 20K devices provide two dedicated clock pins and four dedicated input pins that drive register control inputs. These signals ensure efficient distribution of high-speed, low-skew control signals. These signals use dedicated routing channels to provide short delays and low skews. Four of the dedicated inputs drive four global signals. These four global signals can also be driven by internal logic, providing an ideal solution for a clock divider or internally generated asynchronous clear signals with high fan-out. The dedicated clock pins featured on the APEX 20K devices can also feed logic. The devices also feature ClockLock and ClockBoost clock management circuitry. APEX 20KE devices provide two additional dedicated clock pins, for a total of four dedicated clock pins.

## MegaLAB Structure

APEX 20K devices are constructed from a series of MegaLAB<sup>TM</sup> structures. Each MegaLAB structure contains a group of logic array blocks (LABs), one ESB, and a MegaLAB interconnect, which routes signals within the MegaLAB structure. The EP20K30E device has 10 LABs, EP20K60E through EP20K600E devices have 16 LABs, and the EP20K1000E and EP20K1500E devices have 24 LABs. Signals are routed between MegaLAB structures and I/O pins via the FastTrack Interconnect. In addition, edge LABs can be driven by I/O pins through the local interconnect. Figure 2 shows the MegaLAB structure.

Figure 2. MegaLAB Structure



Each LE has two outputs that drive the local, MegaLAB, or FastTrack Interconnect routing structure. Each output can be driven independently by the LUT's or register's output. For example, the LUT can drive one output while the register drives the other output. This feature, called register packing, improves device utilization because the register and the LUT can be used for unrelated functions. The LE can also drive out registered and unregistered versions of the LUT output.

The APEX 20K architecture provides two types of dedicated high-speed data paths that connect adjacent LEs without using local interconnect paths: carry chains and cascade chains. A carry chain supports high-speed arithmetic functions such as counters and adders, while a cascade chain implements wide-input functions such as equality comparators with minimum delay. Carry and cascade chains connect LEs 1 through 10 in an LAB and all LABs in the same MegaLAB structure.

## Carry Chain

The carry chain provides a very fast carry-forward function between LEs. The carry-in signal from a lower-order bit drives forward into the higher-order bit via the carry chain, and feeds into both the LUT and the next portion of the carry chain. This feature allows the APEX 20K architecture to implement high-speed counters, adders, and comparators of arbitrary width. Carry chain logic can be created automatically by the Quartus II software Compiler during design processing, or manually by the designer during design entry. Parameterized functions such as library of parameterized modules (LPM) and DesignWare functions automatically take advantage of carry chains for the appropriate functions.

The Quartus II software Compiler creates carry chains longer than ten LEs by linking LABs together automatically. For enhanced fitting, a long carry chain skips alternate LABs in a MegaLAB<sup>TM</sup> structure. A carry chain longer than one LAB skips either from an even-numbered LAB to the next even-numbered LAB, or from an odd-numbered LAB to the next odd-numbered LAB. For example, the last LE of the first LAB in the upper-left MegaLAB structure carries to the first LE of the third LAB in the MegaLAB structure.

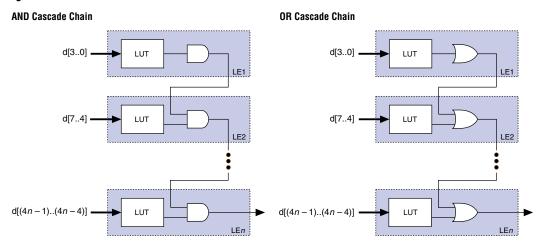
Figure 6 shows how an n-bit full adder can be implemented in n+1 LEs with the carry chain. One portion of the LUT generates the sum of two bits using the input signals and the carry-in signal; the sum is routed to the output of the LE. The register can be bypassed for simple adders or used for accumulator functions. Another portion of the LUT and the carry chain logic generates the carry-out signal, which is routed directly to the carryin signal of the next-higher-order bit. The final carry-out signal is routed to an LE, where it is driven onto the local, MegaLAB, or FastTrack Interconnect routing structures.

#### Cascade Chain

With the cascade chain, the APEX 20K architecture can implement functions with a very wide fan-in. Adjacent LUTs can compute portions of a function in parallel; the cascade chain serially connects the intermediate values. The cascade chain can use a logical AND or logical OR (via De Morgan's inversion) to connect the outputs of adjacent LEs. Each additional LE provides four more inputs to the effective width of a function, with a short cascade delay. Cascade chain logic can be created automatically by the Quartus II software Compiler during design processing, or manually by the designer during design entry.

Cascade chains longer than ten LEs are implemented automatically by linking LABs together. For enhanced fitting, a long cascade chain skips alternate LABs in a MegaLAB structure. A cascade chain longer than one LAB skips either from an even-numbered LAB to the next even-numbered LAB, or from an odd-numbered LAB to the next odd-numbered LAB. For example, the last LE of the first LAB in the upper-left MegaLAB structure carries to the first LE of the third LAB in the MegaLAB structure. Figure 7 shows how the cascade function can connect adjacent LEs to form functions with a wide fan-in.

Figure 7. APEX 20K Cascade Chain



From Previous Macrocell Product-Macrocell Term Product-Select Term Logic Matrix Parallel Expander Switch Product-Macrocell Term Product-Select Term Logic Matrix Parallel Expander Switch 32 Signals from To Next

Figure 16. APEX 20K Parallel Expanders

# Embedded System Block

Local Interconnect

The ESB can implement various types of memory blocks, including dual-port RAM, ROM, FIFO, and CAM blocks. The ESB includes input and output registers; the input registers synchronize writes, and the output registers can pipeline designs to improve system performance. The ESB offers a dual-port mode, which supports simultaneous reads and writes at two different clock frequencies. Figure 17 shows the ESB block diagram.

Macrocell

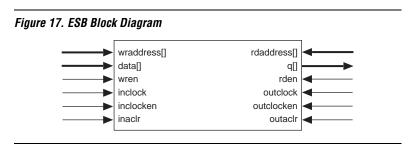


Table 10 describes the APEX 20K programmable delays and their logic options in the Quartus II software.

Table 10. APEX 20K Programmable Delay Chains					
Programmable Delays Quartus II Logic Option					
Input pin to core delay	Decrease input delay to internal cells				
Input pin to input register delay	Decrease input delay to input register				
Core to output register delay Decrease input delay to output register					
Output register t <sub>CO</sub> delay	Increase delay to output pin				

The Quartus II software compiler can program these delays automatically to minimize setup time while providing a zero hold time. Figure 25 shows how fast bidirectional I/Os are implemented in APEX 20K devices.

The register in the APEX 20K IOE can be programmed to power-up high or low after configuration is complete. If it is programmed to power-up low, an asynchronous clear can control the register. If it is programmed to power-up high, the register cannot be asynchronously cleared or preset. This feature is useful for cases where the APEX 20K device controls an active-low input or another device; it prevents inadvertent activation of the input upon power-up.

Under hot socketing conditions, APEX 20KE devices will not sustain any damage, but the I/O pins will drive out.

# MultiVolt I/O Interface

The APEX device architecture supports the MultiVolt I/O interface feature, which allows APEX devices in all packages to interface with systems of different supply voltages. The devices have one set of VCC pins for internal operation and input buffers (VCCINT), and another set for I/O output drivers (VCCIO).

The APEX 20K VCCINT pins must always be connected to a 2.5 V power supply. With a 2.5-V  $V_{CCINT}$  level, input pins are 2.5-V, 3.3-V, and 5.0-V tolerant. The VCCIO pins can be connected to either a 2.5-V or 3.3-V power supply, depending on the output requirements. When VCCIO pins are connected to a 2.5-V power supply, the output levels are compatible with 2.5-V systems. When the VCCIO pins are connected to a 3.3-V power supply, the output high is 3.3 V and is compatible with 3.3-V or 5.0-V systems.

Table 12. 5.0-V Tolerant APEX 20K MultiVolt I/O Support						
V <sub>CCIO</sub> (V)	V) Input Signals (V) Output Signals (V)					
	2.5	3.3	5.0	2.5	3.3	5.0
2.5	✓	<b>√</b> (1)	<b>√</b> (1)	✓		
3.3	<b>✓</b>	✓	<b>√</b> (1)	<b>√</b> (2)	✓	<b>✓</b>

#### Notes to Table 12:

- (1) The PCI clamping diode must be disabled to drive an input with voltages higher than  $V_{\text{CCIO}}$ .
- (2) When  $V_{\rm CCIO}$  = 3.3 V, an APEX 20K device can drive a 2.5-V device with 3.3-V tolerant inputs.

Open-drain output pins on 5.0-V tolerant APEX 20K devices (with a pull-up resistor to the 5.0-V supply) can drive 5.0-V CMOS input pins that require a  $V_{\rm IH}$  of 3.5 V. When the pin is inactive, the trace will be pulled up to 5.0 V by the resistor. The open-drain pin will only drive low or tri-state; it will never drive high. The rise time is dependent on the value of the pull-up resistor and load impedance. The  $I_{\rm OL}$  current specification should be considered when selecting a pull-up resistor.

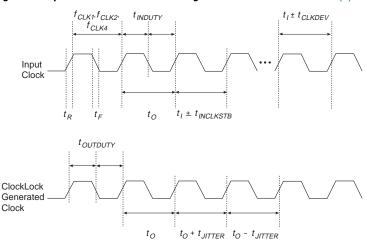


Figure 30. Specifications for the Incoming & Generated Clocks Note (1)

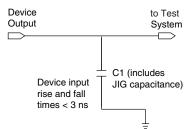
*Note to Figure 30:* 

(1) The tl parameter refers to the nominal input clock period; the tO parameter refers to the nominal output clock period.

Table 15 summarizes the APEX 20K ClockLock and ClockBoost parameters for -1 speed-grade devices.

Symbol	Parameter	Min	Max	Unit	
f <sub>OUT</sub>	Output frequency	25	180	MHz	
f <sub>CLK1</sub> (1)	Input clock frequency (ClockBoost clock multiplication factor equals 1)	25	180 (1)	MHz	
f <sub>CLK2</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 2)	16	90	MHz	
f <sub>CLK4</sub>	Input clock frequency (ClockBoost clock multiplication factor equals 4)	10	48	MHz	
<sup>t</sup> OUTDUTY	Duty cycle for ClockLock/ClockBoost-generated clock	40	60	%	
f <sub>CLKDEV</sub>	Input deviation from user specification in the Quartus II software (ClockBoost clock multiplication factor equals 1) (2)		25,000 (3)	PPM	
t <sub>R</sub>	Input rise time		5	ns	
t <sub>F</sub>	Input fall time		5	ns	
t <sub>LOCK</sub>	Time required for ClockLock/ClockBoost to acquire lock (4)		10	μs	

Figure 32. APEX 20K AC Test Conditions Note (1)



#### Note to Figure 32:

(1) Power supply transients can affect AC measurements. Simultaneous transitions of multiple outputs should be avoided for accurate measurement. Threshold tests must not be performed under AC conditions. Large-amplitude, fast-ground-current transients normally occur as the device outputs discharge the load capacitances. When these transients flow through the parasitic inductance between the device ground pin and the test system ground, significant reductions in observable noise immunity can result.

# Operating Conditions

Tables 23 through 26 provide information on absolute maximum ratings, recommended operating conditions, DC operating conditions, and capacitance for 2.5-V APEX 20K devices.

Table 2	Table 23. APEX 20K 5.0-V Tolerant Device Absolute Maximum Ratings Notes (1), (2)								
Symbol	Parameter	Conditions	Min	Max	Unit				
V <sub>CCINT</sub>	Supply voltage	With respect to ground (3)	-0.5	3.6	V				
V <sub>CCIO</sub>			-0.5	4.6	V				
V <sub>I</sub>	DC input voltage		-2.0	5.75	V				
I <sub>OUT</sub>	DC output current, per pin		-25	25	mA				
T <sub>STG</sub>	Storage temperature	No bias	-65	150	° C				
T <sub>AMB</sub>	Ambient temperature	Under bias	-65	135	° C				
TJ	Junction temperature	PQFP, RQFP, TQFP, and BGA packages, under bias		135	° C				
		Ceramic PGA packages, under bias		150	°C				

		Pevice Recommended Operating Conditio	1	, B#	
Symbol	Parameter	Conditions	Min	Max	Unit
COINT	Supply voltage for internal logic and input buffers	(4), (5)	2.375 (2.375)	2.625 (2.625)	٧
V <sub>CCIO</sub>	Supply voltage for output buffers, 3.3-V operation	(4), (5)	3.00 (3.00)	3.60 (3.60)	٧
	Supply voltage for output buffers, 2.5-V operation	(4), (5)	2.375 (2.375)	2.625 (2.625)	V
V <sub>I</sub>	Input voltage	(3), (6)	-0.5	5.75	V
Vo	Output voltage		0	V <sub>CCIO</sub>	V
T <sub>J</sub>	Junction temperature	For commercial use	0	85	°C
		For industrial use	-40	100	°C
t <sub>R</sub>	Input rise time			40	ns
t <sub>F</sub>	Input fall time			40	ns

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V <sub>IH</sub>	High-level input voltage		1.7, 0.5 × V <sub>CCIO</sub> (9)		5.75	٧
V <sub>IL</sub>	Low-level input voltage		-0.5		0.8, 0.3 × V <sub>CCIO</sub> (9)	٧
V <sub>ОН</sub>	3.3-V high-level TTL output voltage	I <sub>OH</sub> = -8 mA DC, V <sub>CCIO</sub> = 3.00 V (10)	2.4			٧
	3.3-V high-level CMOS output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 3.00 V (10)	V <sub>CCIO</sub> - 0.2			٧
	3.3-V high-level PCI output voltage	$I_{OH} = -0.5 \text{ mA DC},$ $V_{CCIO} = 3.00 \text{ to } 3.60 \text{ V}$ (10)	0.9 × V <sub>CCIO</sub>			V
	2.5-V high-level output voltage	I <sub>OH</sub> = -0.1 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	2.1			٧
		I <sub>OH</sub> = -1 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	2.0			٧
		I <sub>OH</sub> = -2 mA DC, V <sub>CCIO</sub> = 2.30 V (10)	1.7			٧

Table 26. APEX 20K 5.0-V Tolerant Device CapacitanceNotes (2), (14)							
Symbol	Parameter	Conditions	Min	Max	Unit		
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		8	pF		
C <sub>INCLK</sub>	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		12	pF		
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		8	pF		

#### Notes to Tables 23 through 26:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) All APEX 20K devices are 5.0-V tolerant.
- (3) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (4) Numbers in parentheses are for industrial-temperature-range devices.
- (5) Maximum  $V_{CC}$  rise time is 100 ms, and  $V_{CC}$  must rise monotonically.
- (6) All pins, including dedicated inputs, clock I/O, and JTAG pins, may be driven before V<sub>CCINT</sub> and V<sub>CCIO</sub> are powered.
- (7) Typical values are for  $T_A = 25^{\circ}$  C,  $V_{CCINT} = 2.5$  V, and  $V_{CCIO} = 2.5$  or 3.3 V.
- (8) These values are specified in the APEX 20K device recommended operating conditions, shown in Table 26 on page 62.
- (9) The APEX 20K input buffers are compatible with 2.5-V and 3.3-V (LVTTL and LVCMOS) signals. Additionally, the input buffers are 3.3-V PCI compliant when V<sub>CCIO</sub> and V<sub>CCINT</sub> meet the relationship shown in Figure 33 on page 68.
- (10) The I<sub>OH</sub> parameter refers to high-level TTL, PCI or CMOS output current.
- (11) The I<sub>OL</sub> parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (12) This value is specified for normal device operation. The value may vary during power-up.
- (13) Pin pull-up resistance values will be lower if an external source drives the pin higher than  $V_{\text{CCIO}}$ .
- (14) Capacitance is sample-tested only.

Tables 27 through 30 provide information on absolute maximum ratings, recommended operating conditions, DC operating conditions, and capacitance for 1.8-V APEX 20KE devices.

Table 27. APEX 20KE Device Absolute Maximum Ratings Note (1)						
Symbol	Parameter	Conditions	Min	Max	Unit	
V <sub>CCINT</sub>	Supply voltage	With respect to ground (2)	-0.5	2.5	V	
$V_{CCIO}$			-0.5	4.6	٧	
V <sub>I</sub>	DC input voltage		-0.5	4.6	V	
I <sub>OUT</sub>	DC output current, per pin		-25	25	mA	
T <sub>STG</sub>	Storage temperature	No bias	-65	150	° C	
T <sub>AMB</sub>	Ambient temperature	Under bias	-65	135	° C	
TJ	Junction temperature	PQFP, RQFP, TQFP, and BGA packages, under bias		135	° C	
		Ceramic PGA packages, under bias		150	° C	



For DC Operating Specifications on APEX 20KE I/O standards, please refer to *Application Note 117 (Using Selectable I/O Standards in Altera Devices).* 

Table 30. APEX 20KE Device Capacitance   Note (15)							
Symbol	Parameter	Conditions	Min	Max	Unit		
C <sub>IN</sub>	Input capacitance	V <sub>IN</sub> = 0 V, f = 1.0 MHz		8	pF		
C <sub>INCLK</sub>	Input capacitance on dedicated clock pin	V <sub>IN</sub> = 0 V, f = 1.0 MHz		12	pF		
C <sub>OUT</sub>	Output capacitance	V <sub>OUT</sub> = 0 V, f = 1.0 MHz		8	pF		

#### Notes to Tables 27 through 30:

- (1) See the Operating Requirements for Altera Devices Data Sheet.
- (2) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to 5.75 V for input currents less than 100 mA and periods shorter than 20 ns.
- (3) Numbers in parentheses are for industrial-temperature-range devices.
- (4) Maximum V<sub>CC</sub> rise time is 100 ms, and V<sub>CC</sub> must rise monotonically.
- (5) Minimum DC input is -0.5 V. During transitions, the inputs may undershoot to -2.0 V or overshoot to the voltage shown in the following table based on input duty cycle for input currents less than 100 mA. The overshoot is dependent upon duty cycle of the signal. The DC case is equivalent to 100% duty cycle.

Vin Max. Duty Cycle 4.0V 100% (DC) 4.1 90% 4.2 50% 4.3 30% 4.4 17% 4.5 10%

- (6) All pins, including dedicated inputs, clock, I/O, and JTAG pins, may be driven before V<sub>CCINT</sub> and V<sub>CCIO</sub> are powered.
- Typical values are for  $T_A = 25^{\circ}$  C,  $V_{CCINT} = 1.8$  V, and  $V_{CCIO} = 1.8$  V, 2.5 V or 3.3 V.
- (8) These values are specified under the APEX 20KE device recommended operating conditions, shown in Table 24 on page 60.
- (9) Refer to Application Note 117 (Using Selectable I/O Standards in Altera Devices) for the V<sub>IH</sub>, V<sub>IL</sub>, V<sub>OH</sub>, V<sub>OL</sub>, and I<sub>I</sub> parameters when VCCIO = 1.8 V.
- (10) The APEX 20KE input buffers are compatible with 1.8-V, 2.5-V and 3.3-V (LVTTL and LVCMOS) signals. Additionally, the input buffers are 3.3-V PCI compliant. Input buffers also meet specifications for GTL+, CTT, AGP, SSTL-2, SSTL-3, and HSTL.
- (11) The I<sub>OH</sub> parameter refers to high-level TTL, PCI, or CMOS output current.
- (12) The I<sub>OL</sub> parameter refers to low-level TTL, PCI, or CMOS output current. This parameter applies to open-drain pins as well as output pins.
- (13) This value is specified for normal device operation. The value may vary during power-up.
- (14) Pin pull-up resistance values will be lower if an external source drives the pin higher than V<sub>CCIO</sub>.
- (15) Capacitance is sample-tested only.

Figure 33 shows the relationship between  $V_{CCIO}$  and  $V_{CCINT}$  for 3.3-V PCI compliance on APEX 20K devices.

Table 36. APE	X 20KE Routing Timing Microparameters Note (1)
Symbol	Parameter
t <sub>F1-4</sub>	Fanout delay using Local Interconnect
t <sub>F5-20</sub>	Fanout delay estimate using MegaLab Interconnect
t <sub>F20+</sub>	Fanout delay estimate using FastTrack Interconnect

### Note to Table 36:

(1) These parameters are worst-case values for typical applications. Post-compilation timing simulation and timing analysis are required to determine actual worst-case performance.

Table 37. APE	Table 37. APEX 20KE Functional Timing Microparameters							
Symbol	Parameter							
TCH	Minimum clock high time from clock pin							
TCL	Minimum clock low time from clock pin							
TCLRP	LE clear Pulse Width							
TPREP	LE preset pulse width							
TESBCH	Clock high time for ESB							
TESBCL	Clock low time for ESB							
TESBWP	Write pulse width							
TESBRP	Read pulse width							

Tables 38 and 39 describe the APEX 20KE external timing parameters.

Table 38. APEX 20KE External Timing Parameters Note (1)							
Symbol	Clock Parameter	Conditions					
t <sub>INSU</sub>	Setup time with global clock at IOE input register						
t <sub>INH</sub>	Hold time with global clock at IOE input register						
t <sub>OUTCO</sub>	Clock-to-output delay with global clock at IOE output register	C1 = 10 pF					
t <sub>INSUPLL</sub>	Setup time with PLL clock at IOE input register						
t <sub>INHPLL</sub>	Hold time with PLL clock at IOE input register						
t <sub>OUTCOPLL</sub>	Clock-to-output delay with PLL clock at IOE output register	C1 = 10 pF					

Tables 40 through 42 show the  $f_{\mbox{\scriptsize MAX}}$  timing parameters for EP20K100, EP20K200, and EP20K400 APEX 20K devices.

Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Speed Grade		Units	
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.5		0.6		0.8		ns	
t <sub>H</sub>	0.7		0.8		1.0		ns	
t <sub>CO</sub>		0.3		0.4		0.5	ns	
t <sub>LUT</sub>		0.8		1.0		1.3	ns	
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns	
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns	
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns	
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns	
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns	
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns	
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns	
t <sub>ESBDATACO2</sub>		2.6		3.1		3.6	ns	
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns	
t <sub>PD</sub>		2.5		3.0		3.6	ns	
t <sub>PTERMSU</sub>	2.3		2.6		3.2		ns	
t <sub>PTERMCO</sub>		1.5		1.8		2.1	ns	
t <sub>F1-4</sub>		0.5		0.6		0.7	ns	
t <sub>F5-20</sub>		1.6		1.7		1.8	ns	
t <sub>F20+</sub>		2.2		2.2		2.3	ns	
t <sub>CH</sub>	2.0		2.5		3.0		ns	
t <sub>CL</sub>	2.0		2.5		3.0		ns	
t <sub>CLRP</sub>	0.3		0.4		0.4		ns	
t <sub>PREP</sub>	0.5		0.5		0.5		ns	
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns	
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns	
t <sub>ESBWP</sub>	1.6		1.9		2.2		ns	
t <sub>ESBRP</sub>	1.0		1.3		1.4	_	ns	

Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Speed Grade		Units	
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.5		0.6		0.8		ns	
t <sub>H</sub>	0.7		0.8		1.0		ns	
t <sub>CO</sub>		0.3		0.4		0.5	ns	
t <sub>LUT</sub>		0.8		1.0		1.3	ns	
t <sub>ESBRC</sub>		1.7		2.1		2.4	ns	
t <sub>ESBWC</sub>		5.7		6.9		8.1	ns	
t <sub>ESBWESU</sub>	3.3		3.9		4.6		ns	
t <sub>ESBDATASU</sub>	2.2		2.7		3.1		ns	
t <sub>ESBDATAH</sub>	0.6		0.8		0.9		ns	
t <sub>ESBADDRSU</sub>	2.4		2.9		3.3		ns	
t <sub>ESBDATACO1</sub>		1.3		1.6		1.8	ns	
t <sub>ESBDATACO2</sub>		2.6		3.1		3.6	ns	
t <sub>ESBDD</sub>		2.5		3.3		3.6	ns	
t <sub>PD</sub>		2.5		3.0		3.6	ns	
t <sub>PTERMSU</sub>	2.3		2.7		3.2		ns	
t <sub>PTERMCO</sub>		1.5		1.8		2.1	ns	
t <sub>F1-4</sub>		0.5		0.6		0.7	ns	
t <sub>F5-20</sub>		1.6		1.7		1.8	ns	
t <sub>F20+</sub>		2.2		2.2		2.3	ns	
t <sub>CH</sub>	2.0		2.5		3.0		ns	
$t_{CL}$	2.0		2.5		3.0		ns	
t <sub>CLRP</sub>	0.3		0.4		0.4		ns	
t <sub>PREP</sub>	0.4		0.5		0.5		ns	
t <sub>ESBCH</sub>	2.0		2.5		3.0		ns	
t <sub>ESBCL</sub>	2.0		2.5		3.0		ns	
t <sub>ESBWP</sub>	1.6		1.9		2.2		ns	
t <sub>ESBRP</sub>	1.0		1.3	_	1.4		ns	

Tables 55 through 60 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K60E APEX 20KE devices.

Symbol	-	1		-2	-3		Unit
	Min	Max	Min	Max	Min	Max	
t <sub>SU</sub>	0.17		0.15		0.16		ns
t <sub>H</sub>	0.32		0.33		0.39		ns
t <sub>CO</sub>		0.29		0.40		0.60	ns
t <sub>LUT</sub>		0.77		1.07		1.59	ns

Table 62. EP20K	I GOL IMAX LOL	, Thinny Miles	1		T		1
Symbol	-	1		-2	-:	3	Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.61		1.84		1.97	ns
t <sub>ESBSRC</sub>		2.57		2.97		3.20	ns
t <sub>ESBAWC</sub>		0.52		4.09		4.39	ns
t <sub>ESBSWC</sub>		3.17		3.78		4.09	ns
t <sub>ESBWASU</sub>	0.56		6.41		0.63		ns
t <sub>ESBWAH</sub>	0.48		0.54		0.55		ns
t <sub>ESBWDSU</sub>	0.71		0.80		0.81		ns
t <sub>ESBWDH</sub>	.048		0.54		0.55		ns
t <sub>ESBRASU</sub>	1.57		1.75		1.87		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.20		ns
t <sub>ESBWESU</sub>	1.54		1.72		1.80		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.16		-0.20		-0.20		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.12		0.08		0.13		ns
t <sub>ESBRADDRSU</sub>	0.17		0.15		0.19		ns
t <sub>ESBDATACO1</sub>		1.20		1.39		1.52	ns
t <sub>ESBDATACO2</sub>		2.54		2.99		3.22	ns
t <sub>ESBDD</sub>		3.06		3.56		3.85	ns
t <sub>PD</sub>		1.73		2.02		2.20	ns
t <sub>PTERMSU</sub>	1.11		1.26		1.38		ns
t <sub>PTERMCO</sub>		1.19		1.40		1.08	ns

Table 63. EP2	0K100E f <sub>MAX</sub> 1	Routing Delays	s				
Symbol	-	1	-2			Unit	
	Min	Max	Min	Max	Min	Max	1
t <sub>F1-4</sub>		0.24		0.27		0.29	ns
t <sub>F5-20</sub>		1.04		1.26		1.52	ns
t <sub>F20+</sub>		1.12		1.36		1.86	ns

Symbol	-1		-	2	-	Unit	
	Min	Max	Min	Max	Min	Max	
t <sub>INSUBIDIR</sub>	2.86		3.24		3.54		ns
t <sub>INHBIDIR</sub>	0.00		0.00		0.00		ns
t <sub>OUTCOBIDIR</sub>	2.00	5.07	2.00	5.59	2.00	6.13	ns
t <sub>XZBIDIR</sub>		7.43		8.23		8.58	ns
t <sub>ZXBIDIR</sub>		7.43		8.23		8.58	ns
t <sub>INSUBIDIRPLL</sub>	4.93		5.48		-		ns
t <sub>INHBIDIRPLL</sub>	0.00		0.00		-		ns
toutcobidirpll	0.50	3.00	0.50	3.35	-	-	ns
txzbidirpll		5.36		5.99		-	ns
t <sub>ZXBIDIRPLL</sub>		5.36		5.99		-	ns

Tables 73 through 78 describe  $f_{MAX}$  LE Timing Microparameters,  $f_{MAX}$  ESB Timing Microparameters,  $f_{MAX}$  Routing Delays, Minimum Pulse Width Timing Parameters, External Timing Parameters, and External Bidirectional Timing Parameters for EP20K200E APEX 20KE devices.

Table 73. EP2	20K200E f <sub>MAX</sub>	LE Timing Mid	croparameter	s				
Symbol	-	-1		-2	-:	-3		
	Min	Max	Min	Max	Min	Max		
t <sub>SU</sub>	0.23		0.24		0.26		ns	
t <sub>H</sub>	0.23		0.24		0.26		ns	
$t_{CO}$		0.26		0.31		0.36	ns	
t <sub>LUT</sub>		0.70		0.90		1.14	ns	

Table 92. EP20K	600E f <sub>MAX</sub> ESE	3 Timing Micr	oparameters				
Symbol	-1 Spee	d Grade	-2 Spee	-2 Speed Grade		d Grade	Unit
	Min	Max	Min	Max	Min	Max	
t <sub>ESBARC</sub>		1.67		2.39		3.11	ns
t <sub>ESBSRC</sub>		2.27		3.07		3.86	ns
t <sub>ESBAWC</sub>		3.19		4.56		5.93	ns
t <sub>ESBSWC</sub>		3.51		4.62		5.72	ns
t <sub>ESBWASU</sub>	1.46		2.08		2.70		ns
t <sub>ESBWAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWDSU</sub>	1.60		2.29		2.97		ns
t <sub>ESBWDH</sub>	0.00		0.00		0.00		ns
t <sub>ESBRASU</sub>	1.61		2.30		2.99		ns
t <sub>ESBRAH</sub>	0.00		0.00		0.00		ns
t <sub>ESBWESU</sub>	1.49		2.30		3.11		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	-0.01		0.35		0.71		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.19		0.62		1.06		ns
t <sub>ESBRADDRSU</sub>	0.25		0.71		1.17		ns
t <sub>ESBDATACO1</sub>		1.01		1.19		1.37	ns
t <sub>ESBDATACO2</sub>		2.18		3.12		4.05	ns
t <sub>ESBDD</sub>		3.19		4.56		5.93	ns
t <sub>PD</sub>		1.57		2.25		2.92	ns
t <sub>PTERMSU</sub>	0.85		1.43		2.01		ns
t <sub>PTERMCO</sub>		1.03		1.21		1.39	ns

Table 93. EP2	OK600E f <sub>MAX</sub>	Routing Delays	s				
Symbol	-1 Spee	d Grade	-2 Speed Grade		-3 Spee	d Grade	Unit
	Min	Max	Min	Max	Min	Max	
t <sub>F1-4</sub>		0.22		0.25		0.26	ns
t <sub>F5-20</sub>		1.26		1.39		1.52	ns
t <sub>F20+</sub>		3.51		3.88		4.26	ns

Symbol	-1 Speed Grade		-2 Speed Grade		-3 Speed Grade		Unit
	Min	Max	Min	Max	Min	Max	1
t <sub>ESBARC</sub>		1.78		2.02		1.95	ns
t <sub>ESBSRC</sub>		2.52		2.91		3.14	ns
t <sub>ESBAWC</sub>		3.52		4.11		4.40	ns
t <sub>ESBSWC</sub>		3.23		3.84		4.16	ns
t <sub>ESBWASU</sub>	0.62		0.67		0.61		ns
t <sub>ESBWAH</sub>	0.41		0.55		0.55		ns
t <sub>ESBWDSU</sub>	0.77		0.79		0.81		ns
t <sub>ESBWDH</sub>	0.41		0.55		0.55		ns
t <sub>ESBRASU</sub>	1.74		1.92		1.85		ns
t <sub>ESBRAH</sub>	0.00		0.01		0.23		ns
t <sub>ESBWESU</sub>	2.07		2.28		2.41		ns
t <sub>ESBWEH</sub>	0.00		0.00		0.00		ns
t <sub>ESBDATASU</sub>	0.25		0.27		0.29		ns
t <sub>ESBDATAH</sub>	0.13		0.13		0.13		ns
t <sub>ESBWADDRSU</sub>	0.11		0.04		0.11		ns
t <sub>ESBRADDRSU</sub>	0.14		0.11		0.16		ns
t <sub>ESBDATACO1</sub>		1.29		1.50		1.63	ns
t <sub>ESBDATACO2</sub>		2.55		2.99		3.22	ns
t <sub>ESBDD</sub>		3.12		3.57		3.85	ns
t <sub>PD</sub>		1.84		2.13		2.32	ns
t <sub>PTERMSU</sub>	1.08		1.19		1.32		ns

1.53

1.66

ns

1.31

 $t_{\text{PTERMCO}}$